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Magnetic field effects on the electroluminescence of organic light emitting devices: A tool to indicate the carrier mobility

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The magnetoelectroluminescence (MEL) of organic light emitting devices with a N,N'-bis(1-naphthyl)-N,N'-diphenyl-1,1'-biphenyl-4,4'-diamine:tris-(8-hydroxyquinoline) aluminum (NPB:Alq₃) mixed emission layer (EML) has been investigated. We find that MEL is maximized when the volume ratio of NPB of the mixed EML reaches 30% and the EML thickness is 40 nm. The features of MEL under various magnetic field strengths are insensitive to the change in EML thickness and mixing ratio. Meanwhile, MEL has a close relationship with the carrier mobility. We have conducted a theoretical study to further verify the relationship. Our experimental and theoretical results confirm that MEL can function as a tool to indicate the mobility. © 2010 American Institute of Physics. [doi:10.1063/1.3505343]

Magnetic field can moderately modify the electroluminescence (EL) of organic light emitting devices (OLEDs), namely, organic magnetoelectroluminescence (MEL).¹⁻⁵ MEL is quantitatively expressed with $\Delta EL/EL = [(EL(B) - EL(0)) / EL(0)]$, where $EL(B)$ and $EL(0)$ are the EL intensity with and without external magnetic field B , respectively.⁶ MEL provides a reliable way to investigate the spin related exciton dynamics,⁶⁻¹⁰ the mechanism of the carrier-to-photon conversion in organic semiconductors,⁸⁻¹² and even the operation mechanism of magnetic sensor and avian magnetic compass.¹³ Some methods have been used to control and tune MEL, such as changing applied voltage^{4,5,12,14} and inserting insulating layer of LiF.⁵ However, it is still not clear which factor governs MEL. It is because any change in the applied voltage will modify the electric field and exciton density simultaneously, and all of them can cause change in MEL.

In this letter, an OLED structure with the composite light emitting layer (EML) is designed to tune the MEL. The MEL is optimized by change the EML thickness and the volume ratio of N,N'-bis(1-naphthyl)-N,N'-diphenyl-1,1'-biphenyl-4,4'-diamine (NPB) of the EML. Our results show that MEL is very sensitive and inversely related to the carrier mobility of the organic semiconductors. The relationship between the carrier mobility and the MEL is verified by the carrier hopping rate through our theoretical study of the MEL. The results confirm that MEL can contribute to diagnose the carrier mobility of an organic semiconductor.

The device structure is shown in Fig. 1(a). The fluorescent EML with a thickness of 20 nm composes of tris-(8-hydroxyquinoline) aluminum (Alq₃) and NPB. The emitting area is approximately 4×4 mm². The 40-nm-thick NPB and 50 nm-thick Alq₃ form the hole-transport and electron-transport layers, respectively. ITO and Al/LiF are anode and composite cathode, respectively. By applying magnetic field to the OLEDs, the brightness of the EL will be increased.

Figure 1(b) shows the $\Delta EL/EL$ (i.e., MEL) of the OLEDs with eight different volume ratios of NPB varying from 0% to 100%. At low magnetic field (i.e., 0–15 mT), the increment of brightness is large, while at high magnetic field (>20 mT), the brightness almost saturates. The inset of Fig. 1(b) shows that the normalized MELs of eight devices have the same trend. The result indicates that the features of MEL

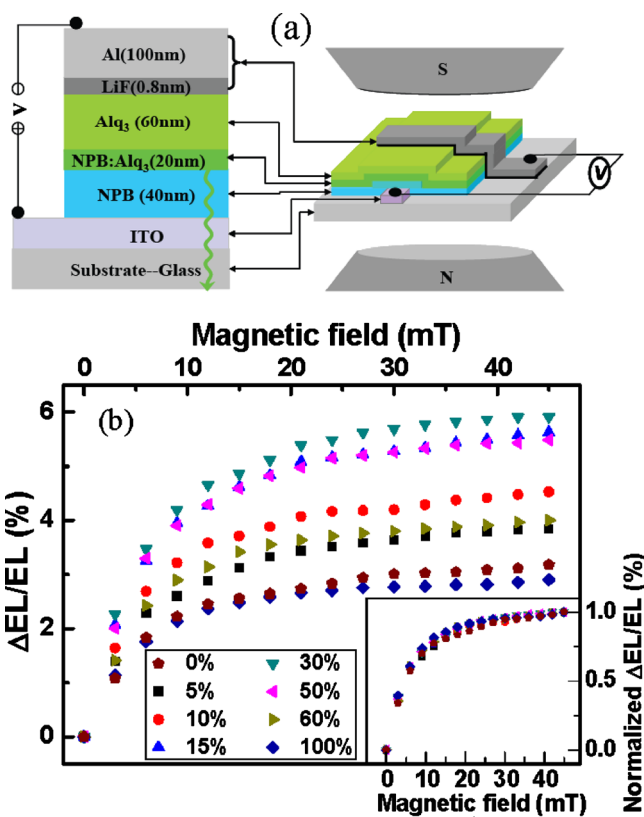


FIG. 1. (Color online) (a) A schematic view of the device structure. (b) The experimental MEL of the eight OLEDs with different NPB concentrations in the EML. All devices are driven at 500 μ A. Inset shows the normalized MEL.

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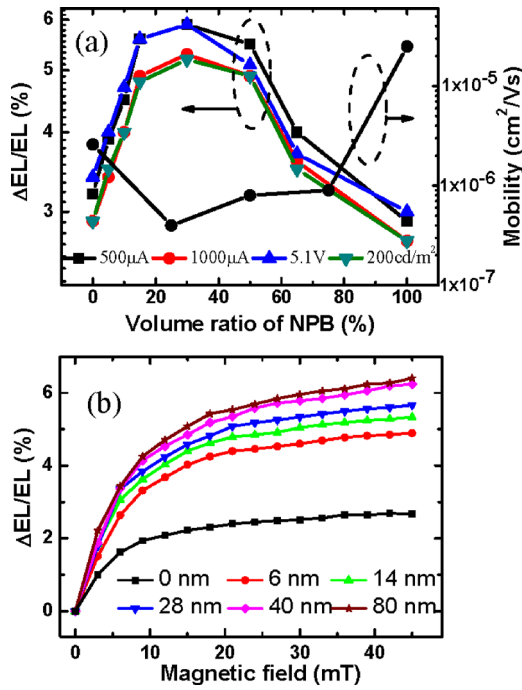


FIG. 2. (Color online) (a) MEL vs the volume ratio of NPB of the mixed EML at a fixed magnetic field of 45 mT. Four different driving modes including constant current driving of 500 and 1000 μA , constant voltage driving of 5.1 V and constant initial brightness of 200 cd/m^2 . Black circle dot denotes the experimental electron mobility of NPB:Alq₃ mixed materials taken from Ref. 15. (b) MEL of the six devices with different EML thicknesses. The OLEDs were driven at 1000 μA .

(i.e., $\Delta EL/EL$) with the strength of magnetic field are insensitive with the change in concentration ratio but not the true value of $\Delta EL/EL$.

In order to intuitively show the concentration effects (and thus study the mobility effects) of the mixed EML on the value of $\Delta EL/EL$, the $\Delta EL/EL$ of the eight devices at a given magnetic field of 45 mT is plotted in Fig. 2(a). The devices are driven at four different modes. Take the MEL under the constant driving current of 1000 μA as an example, by varying the volume ratio of NPB from 0% to 30%, $\Delta EL/EL$ increases from 2.9% to 5.3%. When the volume ratio is further increased from 30% to 100%, $\Delta EL/EL$ decreases from 5.3% to 2.7%. The optimized volume ratio therefore is 30%. The MELs under other three driving modes including constant current 500 μA , constant voltage 5.1 V, and constant initial brightness 200 cd/m^2 all reveal that 30% is the optimized ratio for maximizing the MEL. More importantly, the unique feature of the MEL with the concentration of the mixed EML is merely from the concentration effect and not due to the driving conditions. The unique feature can be used to diagnose the carrier mobility of the organic semiconductor as will be discussed later.

In fact, the MEL is can be further enhanced by changing the thickness of the mixed EML. Figure 2(b) shows the OLEDs with six different EML thickness including 0, 6, 14, 28, 40, and 80 nm. The device structure is ITO/NPB(50-x/2 nm)/NPB:Alq₃(x nm)/Alq₃(60-x/2)/LiF/Al. The total thickness of the devices is constant and all volume ratio of NPB in the mixed EML is fixed at 30%. The normalized $\Delta EL/EL$ s of these OLEDs show the similar trend as that in the inset of Fig. 2(a). Consequently, the trend of MEL with

the strength of magnetic field is insensitive with the change in concentration and thickness of the EML.

Concerning the magnitude of the $\Delta EL/EL$, when the thickness of EML increases from 0 to 40 nm, the magnitude increases in the whole range of the applied magnetic field. For the thickness from 40 to 80 nm, the enhancement with thickness of blended layer is almost saturated. As shown in Fig. 2(b), at the given magnetic field of 45 mT, $\Delta EL/EL$ increases from 2.5% to 6.3% when the thickness increases from 0 to 40 nm. However, $\Delta EL/EL$ only changes from 6.3% to 6.5% when the thickness is further increased from 40 to 80 nm. Consequently, with the increase in emission region, the $\Delta EL/EL$ can be increased and optimized at about 40 nm.

Interestingly, we find that MEL is very sensitive to the carrier mobility of the devices. When the electrical bias to the OLED reduces, the whole $\Delta EL/EL$ spectrum with the magnetic field reduces except the case of no magnetic field at which $\Delta EL/EL=0$ (the plot is not shown). For a given OLED, considering $V=\int_0^d E(x)dx$, where V is the driving voltage, E is the electric field and d is the thickness of the device. When the voltage reduces, the electric field in the organic structure reduces. Meanwhile, through the formula of $\mu(E)=\mu(0)\exp(\gamma\sqrt{E})$, where $\mu(E)$ is the carrier mobility at an applied field of E , $\mu(0)$ is the zero-field carrier mobility and γ is the Poole-Frenkel slope, we can see that when the electric field reduces, the carrier mobility drops but the $\Delta EL/EL$ (i.e., MEL) increases. This feature can be confirmed by our results as shown in Fig. 2(a). The results show that the $\Delta EL/EL$ is maximized when the volume ratio of NPB is around 30%. We also plot the electron mobility of the mixed NPB:Alq₃ taken from Ref. 15. Remarkably, the peak of the $\Delta EL/EL$ is almost at the trough of the measured mobility.^{15,16}

In theory, we have introduced the Hubbard model¹⁷ to describe the feature trend of the $\Delta EL/EL$. The Hamiltonian, including both the intermolecular transportation of electrons/holes and the interaction between electrons/holes and nuclear spins, is described as,

$$H = H_1 + H_2, \quad (1)$$

where H_1 includes hopping and Coulomb interaction of carriers as

$$H_1 = - \sum_{i,j,\sigma} (t_{i,i'}^h d_{i,\sigma}^* d_{i',\sigma} + t_{j,j'}^e c_{j,\sigma}^* c_{j',\sigma} + h.c.) + U \sum_{i,j} (n_{i,\uparrow}^h n_{i,\downarrow}^h + n_{i,\uparrow}^e n_{i,\downarrow}^e) + V. \quad (2)$$

In Eq. (2), $d_{j,\sigma}^*$ ($d_{j,\sigma}$) and $c_{j,\sigma}^*$ ($c_{j,\sigma}$) are the creation (annihilation) operators of hole and electron, respectively. The hole and electron have spin σ which can be spin up (\uparrow) or down (\downarrow) in the i th and j th molecule. i' and j' denote the neighbors of the i th and j th molecule, respectively, $t_{i,i'}^h$ ($t_{j,j'}^e$) is the hopping rate of hole between the i th and i' th molecules (electron between j th and j' th molecules) with a unit of microelectron volt. U is the Coulomb repulsive energy between two holes or two electrons with different spins at the same molecule. $n_{i,\sigma}^h$ ($\equiv d_{i,\sigma}^* d_{i,\sigma}$) and $n_{i,\sigma}^e$ ($\equiv c_{j,\sigma}^* c_{j,\sigma}$) are the corresponding creation and annihilation multiplied operators of hole and electron, and V is the attractive interaction between hole and electron at the same molecule.

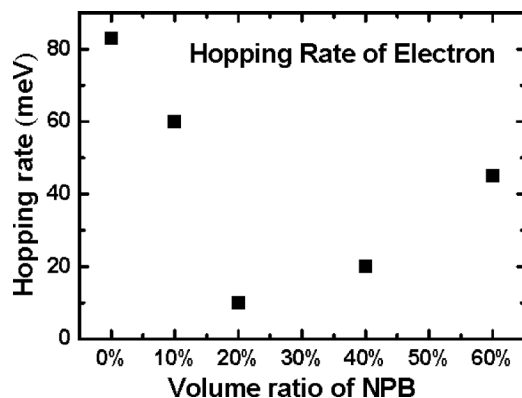


FIG. 3. The theoretical electron hopping rate of the OLEDs with NPB:Alq₃ mixed EML.

H_2 includes the effect of an external magnetic field and hyperfine interactions and can be expressed as

$$H_2 = g\mu_B \sum_{i,j} [(\vec{B}_{\text{ext}} + \vec{B}_{\text{hyp},i}) \cdot \vec{S}_i^h + (\vec{B}_{\text{ext}} + \vec{B}_{\text{hyp},j}) \cdot \vec{S}_j^e], \quad (3)$$

where $g=2.0$ for organic materials,¹⁸ μ_B is Bohr magneton, \vec{B}_{ext} is the external magnetic field chosen to be along the z-direction, and $\vec{B}_{\text{hyp},i(j)}$ is the effective nuclear magnetic field of the i th (j th) molecule, \vec{S}_i^h and \vec{S}_j^e are the classical spin vectors of the hole and electron in the i th and j th molecules, respectively. In this work, we mainly study the relationship between the hopping rate of the carrier and MEL. Therefore, only the hopping rate is variable. Generally, hopping rates $t_{i,i'}^h$ and $t_{j,j'}^e$ vary from molecule to molecule due to the disorder arrangement of organic materials. Their values are typically between 1 and 100 μeV .^{15,19}

With the Hubbard model, the theoretical hopping rate of electron can be determined as shown in Fig. 3. It can be seen that the change in the hopping rate of electron with the volume ratio of NPB in the mixed EML is with the similar trend as that of the experimental electron mobility as shown in Fig. 2(a). The MEL is inverted related to the carrier hopping rate and mobility. Meanwhile, the maximum MEL can be obtained when the carrier mobility is at its minimum. This can provide further evidence that MEL can be used as a tool to diagnose the carrier mobility of an organic material.

In conclusion, we have presented how to use the composite EML layer compositing from NPB and Alq₃ to tune and control the MEL of organic semiconductor devices. The optimized MEL is achieved when the mixed EML has NPB

volume ratio of 30% and thickness of 40 nm. Our results show that carrier mobility is a dominant factor to determine the intensity of MEL. The trend of MEL is opposite to that of the mobility of organic semiconductors. Our finding offers a way to tune MEL in OLEDs. In addition, we can use MEL as a tool to reflect the mobility of OLEDs.

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